Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/678,804	DEVOS ET AL.	
Examiner	**Art Unit**	
L. E. Crane	1623	

SEARCHED			
Class	Subclass	Date	Examiner
536	27.61, 28.5, 28.51, 28.52	3/29/2006	LEC
536	29.2	3/29/2006	LEC
536	28.2	3/29/2006	LEC
536	28.54	3/29/2006	LEC
536	28.55	3/29/2006	LEC
536	27.21	3/29/2006	LEC
536	27.62	3/29/2006	LEC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Review of STN structure, West classification, and PTO/PALM inventor name searches from the parent application, 09/923,620	3/29/2006	LEC